MSKSEMI















ESD

TVS

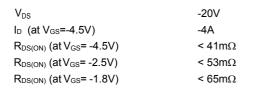
TSS

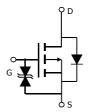
MOV

GDT

PLED

Broduct data speet





ESD protected

Absolute Maximum Ratings T _A =25°C unless otherwise noted					
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	-20	V	
Gate-Source Voltage		V _{GS}	±8 \		
Continuous Drain	T _A =25°C	I-	-4		
Current	T _A =70°C	ID	-3.5	A	
Pulsed Drain Current	C	I _{DM}	-30		
	T _A =25°C	P _D	1.5	W	
Power Dissipation ^B	T _A =70°C		1		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

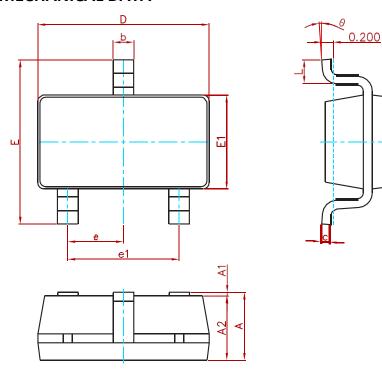
Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	В	65	80	°C/W
Maximum Junction-to-Ambient A D	Steady-State	$R_{\theta JA}$	85	100	°C/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	43	52	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V		-20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-20V, V _{GS} =0V				-1	
			T _J =55°C			-5	μА
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±8V				±10	μΑ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=-250\mu A$		-0.3	-0.57	-0.9	V
$I_{D(ON)}$	On state drain current	V _{GS} =-4.5V, V _{DS} =-5V		-30			Α
		V _{GS} =-4.5V, I _D =-4A			34	41	mΩ
			T _J =125°C		49	59	1115.2
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-2.5V, I _D =-4A			42	53	mΩ
		V _{GS} =-1.8V, I _D =-2A			52	65	mΩ
		V _{GS} =-1.5V, I _D =-1A			61		mΩ
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-4A			20		S
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-0.64	-1	V
Is	Maximum Body-Diode Continuous Current				-2	Α	
DYNAMI	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-10V, f=1MHz		600	751	905	pF
C _{oss}	Output Capacitance			80	115	150	pF
C _{rss}	Reverse Transfer Capacitance			48	80	115	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		6	13	20	Ω
SWITCH	ING PARAMETERS						
Q_g	Total Gate Charge			7.4	9.3	11	nC
Q_{gs}	Gate Source Charge	V _{GS} =-4.5V, V _{DS} =-10V, I _D =-4A		0.8	1	1.2	nC
Q_{gd}	Gate Drain Charge			1.3	2.2	3.1	nC
t _{D(on)}	Turn-On DelayTime				13		ns
t _r	Turn-On Rise Time	V_{GS} =-4.5V, V_{DS} =-10V, R_L =2.5 Ω , R_{GEN} =3 Ω			9		ns
t _{D(off)}	Turn-Off DelayTime				19		ns
t _f	Turn-Off Fall Time				29		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-4A, dI/dt=500A/μ:	s	20	26	32	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-4A, dI/dt=500A/μ:	s	40	51	62	nC

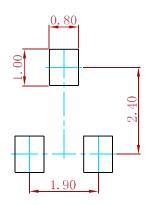


PACKAGE MECHANICAL DATA



Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
Syllibol	Min.	Max.	Min.	Max.	
А	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
0	0°	8°	0°	8°	

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3415AI-MS	SOT-23	3000



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